Notice of References Cited Application/Control No. 09/844,920 Examiner THUAN T. NGUYEN Applicant(s)/Patent Under Reexamination SIBLEY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|------------------|----------------|
| | Α | US-6,381,747 B1 | 04-2002 | Wonfor et al. | 725/104 |
| | В | US-6,543,050 B1 | 04-2003 | Letellier et al. | 725/31 |
| | С | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | к | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | TOTAL ALEIT DOCUMENTS | | | | | | | |
|---|-----------------------|---|--|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.